

IS62V6416BL/LL

64K x 16 LOW VOLTAGE, ULTRA LOW POWER CMOS STATIC RAM

ADVANCE INFORMATION
MAY 1999

FEATURES

- Access time: 70, 100, and 120 ns
- CMOS low power operation
- TTL compatible interface levels
- Single 2.7V-3.6V power supply
- Fully static operation: no clock or refresh required
- Three state outputs
- Data control for upper and lower bytes
- Industrial temperature available
- Available in Jedec Std 44-pin SOJ package, 44-pin TSOP (Type II), and 48-pin mini BGA

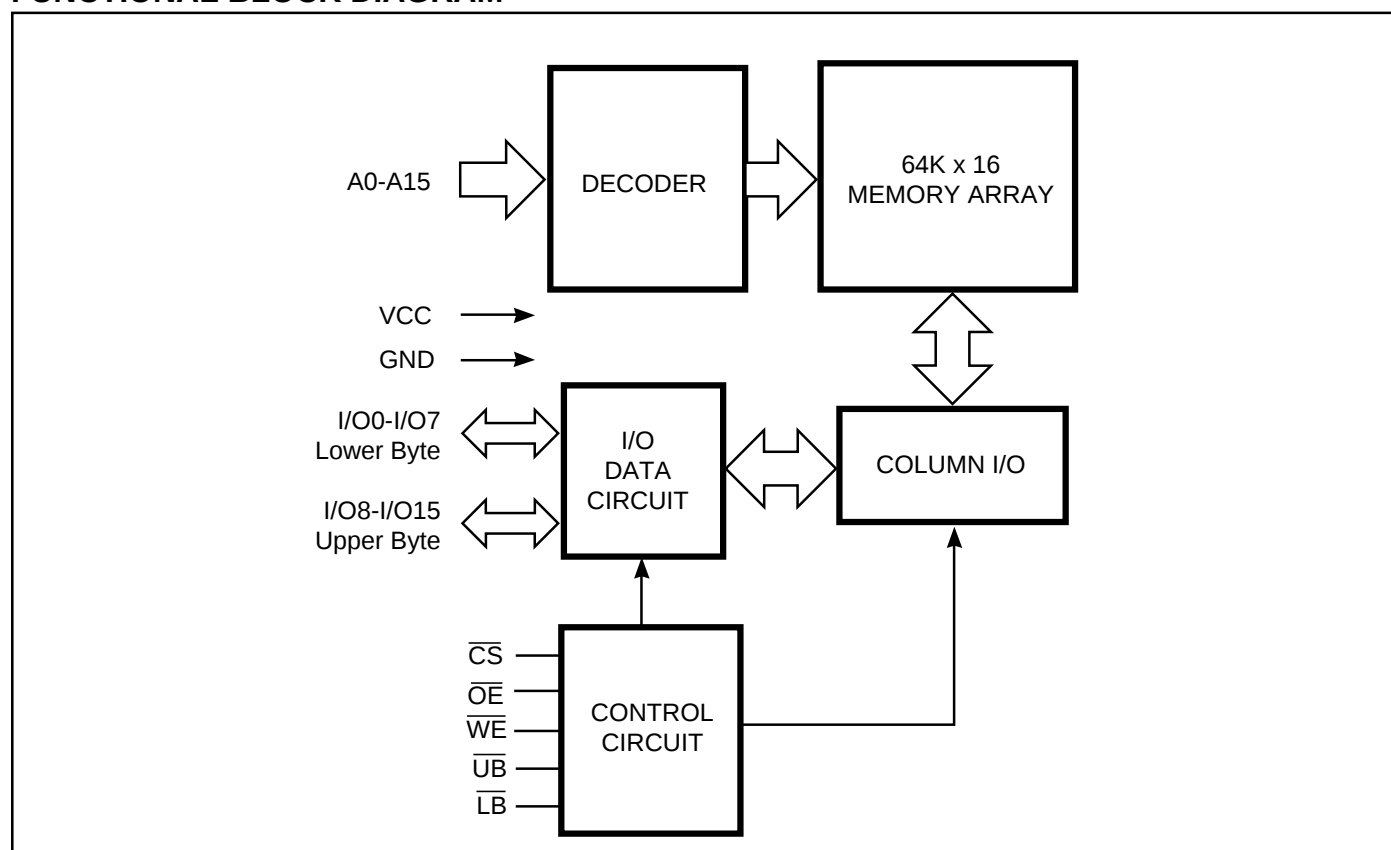
DESCRIPTION

The *ISSI* IS62V6416BL/LL is an ultra-low power, 1,048,576-bit static RAM organized as 65,536 words by 16 bits. It is fabricated using *ISSI*'s high-performance CMOS technology. This highly reliable process coupled with innovative circuit design techniques yields access times as fast as 70 ns with low power consumption.

When $\overline{CS}$ is HIGH (deselected) or when $\overline{CS}$ is LOW and both $\overline{LB}$ and $\overline{UB}$ are HIGH, the device assumes a standby mode at which the power dissipation can be reduced down with CMOS input levels.

Easy memory expansion is provided by using Chip Select and Output Enable inputs, $\overline{CS}$ and $\overline{OE}$. The active LOW Write Enable ($\overline{WE}$) controls both writing and reading of the memory. A data byte allows Upper Byte ($\overline{UB}$) and Lower Byte ($\overline{LB}$) access.

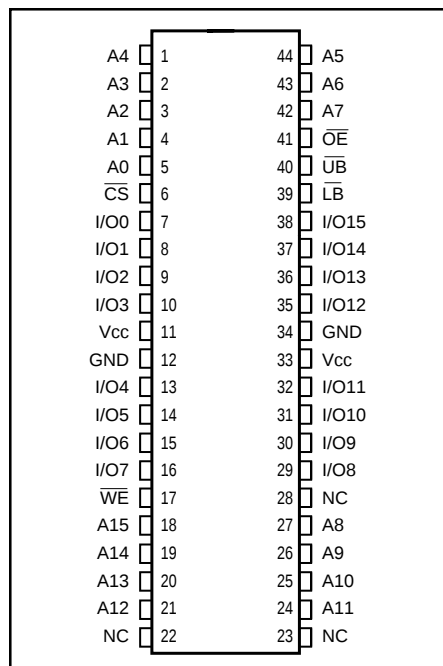
FUNCTIONAL BLOCK DIAGRAM



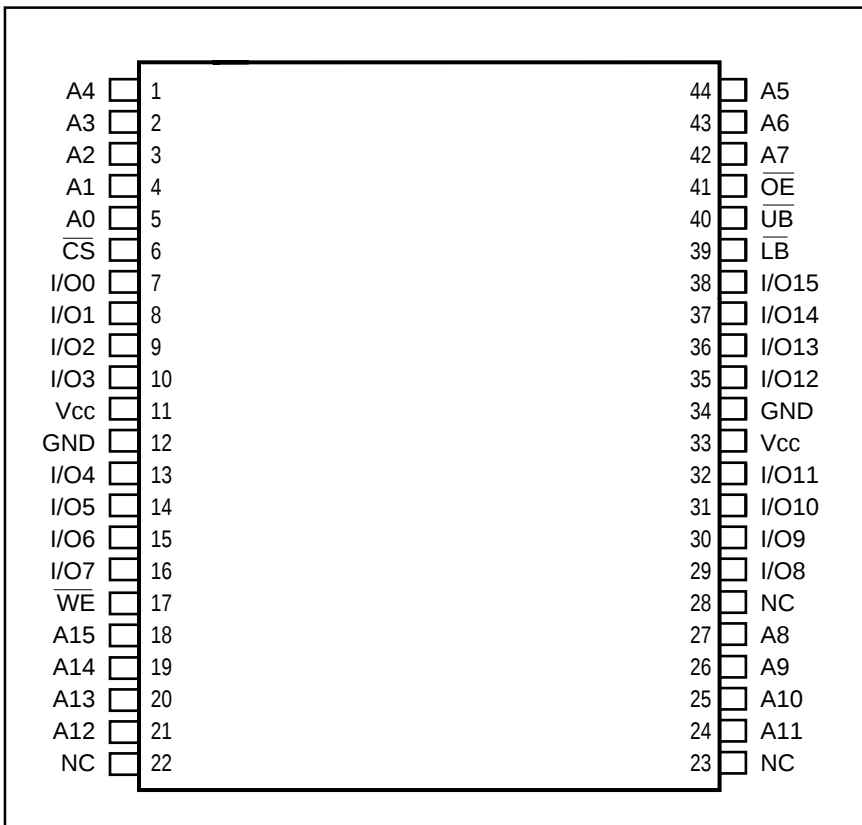
The specification contains ADVANCE INFORMATION. ISSI reserves the right to make changes to its products at any time without notice in order to improve design and supply the best possible product. We assume no responsibility for any errors which may appear in this publication. © Copyright 1999, Integrated Silicon Solution, Inc.

PIN CONFIGURATIONS

44-Pin SOJ



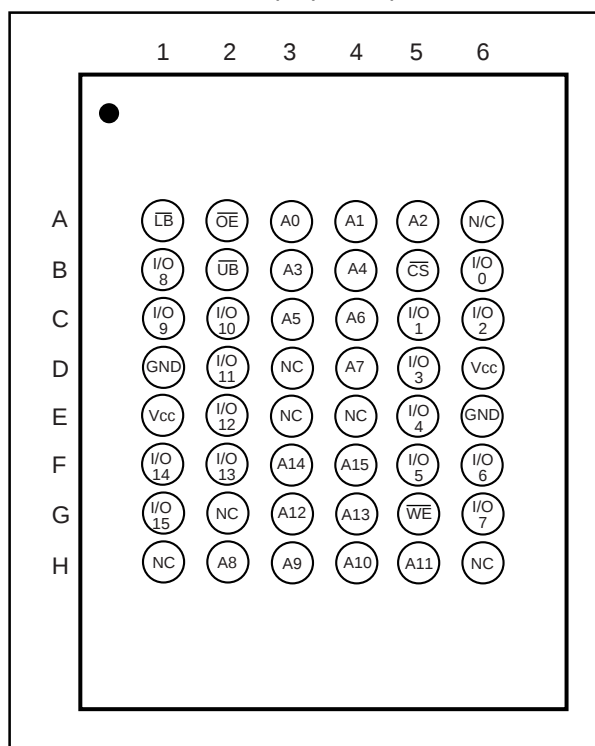
44-Pin TSOP



PIN DESCRIPTIONS

A0-A15	Address Inputs
I/O0-I/O15	Data Inputs/Outputs
$\overline{CS}$	Chip Enable Input
$\overline{OE}$	Output Enable Input
$\overline{WE}$	Write Enable Input
$\overline{LB}$	Lower-byte Control (I/O0-I/O7)
$\overline{UB}$	Upper-byte Control (I/O8-I/O15)
NC	No Connection
Vcc	Power
GND	Ground

48-Pin mini BGA (Top View)



TRUTH TABLE

Mode	$\overline{WE}$	$\overline{CS}$	$\overline{OE}$	$\overline{LB}$	$\overline{UB}$	I/O Pin		Vcc Current
						I/O0-I/O7	I/O8-I/O15	
Not Selected	X	H	X	X	X	High-Z	High-Z	IsB1, IsB2
	X	L	X	H	H	High-Z	High-Z	IsB1, IsB2
Output Disabled	H	L	H	L	L	High-Z	High-Z	Icc
Read	H	L	L	L	H	DOUT	High-Z	Icc
	H	L	L	H	L	High-Z	DOUT	
	H	L	L	L	L	DOUT	DOUT	
Write	L	L	X	L	H	DIN	High-Z	Icc
	L	L	X	H	L	High-Z	DIN	
	L	L	X	L	L	DIN	DIN	

AC TEST CONDITIONS

Parameter	Unit
Input Pulse Level	0 to 3V ⁽¹⁾
Input Rise and Fall Times	5 ns
Input and Output Timing and Reference Level	1.5V ⁽¹⁾
Output Load	See Figures 1 and 2

AC TEST LOADS

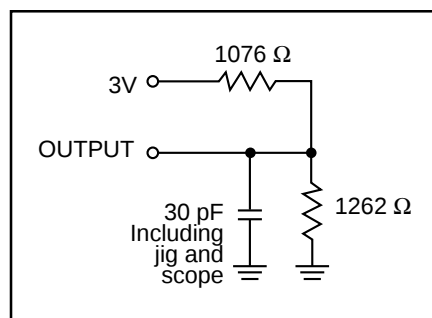


Figure 1.

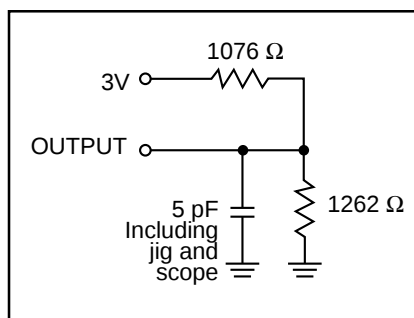


Figure 2.

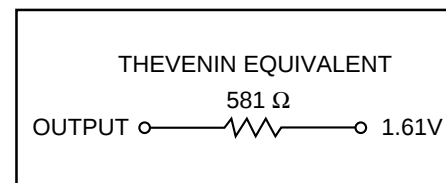


Figure 3.

ABSOLUTE MAXIMUM RATINGS⁽¹⁾

Symbol	Parameter	Value	Unit
V _{TERM}	Terminal Voltage with Respect to GND	−0.5 to V _{CC} +0.5	V
T _{STG}	Storage Temperature	−65 to +150	°C
P _T	Power Dissipation	1.5	W
I _{OUT}	DC Output Current (LOW)	20	mA

Note:

1. Stress greater than those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

OPERATING RANGE

Range	Ambient Temperature	V _{CC}
Commercial	0°C to +70°C	2.7V (Min.) to 3.6V (Max.)
Industrial	−40°C to +85°C	2.7V (Min.) to 3.6V (Max.)

DC ELECTRICAL CHARACTERISTICS (Over Operating Range Unless Otherwise Specified)

Symbol	Parameter	Test Conditions	Min.	Max.	Unit
V _{OH}	Output HIGH Voltage	V _{CC} = Min., I _{OH} = −1 mA	2.2	—	V
V _{OL}	Output LOW Voltage	V _{CC} = Min., I _{OL} = 2.1 mA	—	0.4	V
V _{IH}	Input HIGH Voltage		2.0	V _{CC} + 0.3	V
V _{IL} ⁽¹⁾	Input LOW Voltage		−0.2	0.4	V
I _{LI}	Input Leakage	GND ≤ V _{IN} ≤ V _{CC}	−1	1	μA
I _{LO}	Output Leakage	GND ≤ V _{OUT} ≤ V _{CC} , Outputs Disabled	−1	1	μA

Note:

1. V_{IL} (min.) = −1.5V for pulse width less than 30 ns.

IS62V6416BL/LL

IS62V6416BL:

POWER SUPPLY CHARACTERISTICS⁽¹⁾ (Over Operating Range Unless Otherwise Specified)

Symbol	Parameter	Test Conditions		-70		-100		-120		Unit
				Min.	Max.	Min.	Max.	Min.	Max.	
I _{CC}	V _{CC} Dynamic Operating Supply Current	V _{CC} = Max.,	Com.	—	50	—	35	—	30	mA
		I _{OUT} = 0 mA, f = f _{MAX}	Ind.	—	65	—	45	—	40	
		$\overline{CS} = V_{IH}$								
I _{SB1}	TTL Standby Current (TTL Inputs)	V _{CC} = Max.,	Com.	—	0.3	—	0.3	—	0.3	mA
		V _{IN} = V _{IH} or V _{IL}	Ind.	—	0.3	—	0.3	—	0.3	
		$\overline{CS} \geq V_{IH}$, f = 0								
OR										
	ULB Control	$V_{CC} = \text{Max.}, V_{IN} = V_{IH} \text{ or } V_{IL}$ $\overline{CS} = V_{IL}, f = 0, \overline{UB} = V_{IH}, \overline{LB} = V_{IH}$								
I _{SB2}	CMOS Standby Current (CMOS Inputs)	V _{CC} = Max.,	Com.	—	15	—	15	—	15	μA
		$\overline{CS} \geq V_{CC} - 0.2V$	Ind.	—	15	—	15	—	15	
		V _{IN} ≤ 0.2V, f = 0								
OR										
	ULB Control	$V_{CC} = \text{Max.}, \overline{CS} = V_{IL}$ $V_{IN} \leq 0.2V, f = 0; \overline{UB} / \overline{LB} = V_{CC} - 0.2V$								

IS62V6416BLL:

POWER SUPPLY CHARACTERISTICS⁽¹⁾ (Over Operating Range Unless Otherwise Specified)

Symbol	Parameter	Test Conditions		-70		-100		-120		Unit
				Min.	Max.	Min.	Max.	Min.	Max.	
I _{CC}	V _{CC} Dynamic Operating Supply Current	V _{CC} = Max.,	Com.	—	50	—	35	—	30	mA
		I _{OUT} = 0 mA, f = f _{MAX}	Ind.	—	65	—	45	—	40	
		CS = V _{IH}								
I _{SB1}	TTL Standby Current (TTL Inputs)	V _{CC} = Max.,	Com.	—	0.3	—	0.3	—	0.3	mA
		V _{IN} = V _{IH} or V _{IL}	Ind.	—	0.3	—	0.3	—	0.3	
		CS ≥ V _{IH} , f = 0								
OR										
	ULB Control	V _{CC} = Max., V _{IN} = V _{IH} or V _{IL} CS = V _{IL} , f = 0, UB = V _{IH} , LB = V _{IH}								
I _{SB2}	CMOS Standby Current (CMOS Inputs)	V _{CC} = Max.,	Com.	—	5	—	5	—	5	μA
		CS ≥ V _{CC} – 0.2V	Ind.	—	5	—	5	—	5	
		V _{IN} ≤ 0.2V, f = 0								
OR										
	ULB Control	V _{CC} = Max., CS = V _{IL} V _{IN} ≤ 0.2V, f = 0; UB / LB = V _{CC} – 0.2V								

Note:

1. At f = f_{MAX}, address and data inputs are cycling at the maximum frequency; f = 0 means no input lines change.

CAPACITANCE⁽¹⁾

Symbol	Parameter	Conditions	Max.	Unit
C _{IN}	Input Capacitance	V _{IN} = 0V	8	pF
C _{OUT}	Input/Output Capacitance	V _{OUT} = 0V	10	pF

Note:

1. Tested initially and after any design or process changes that may affect these parameters.

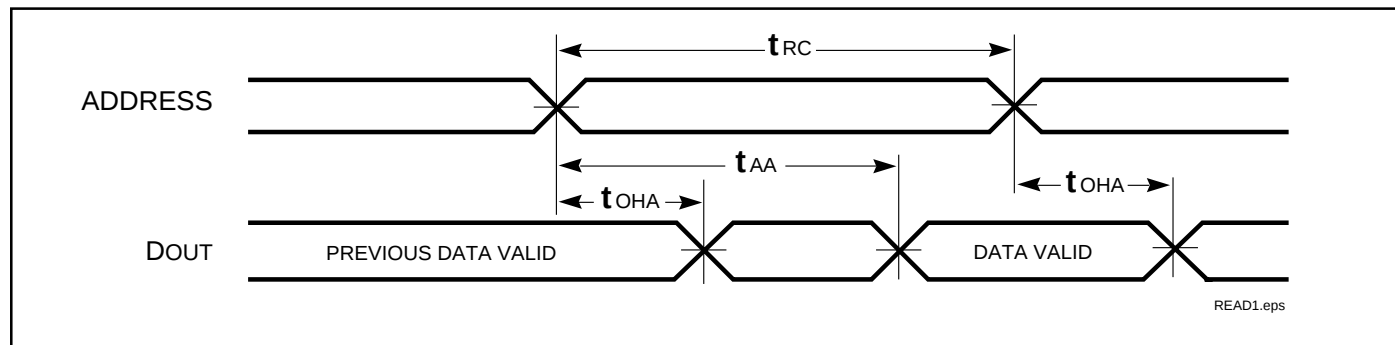
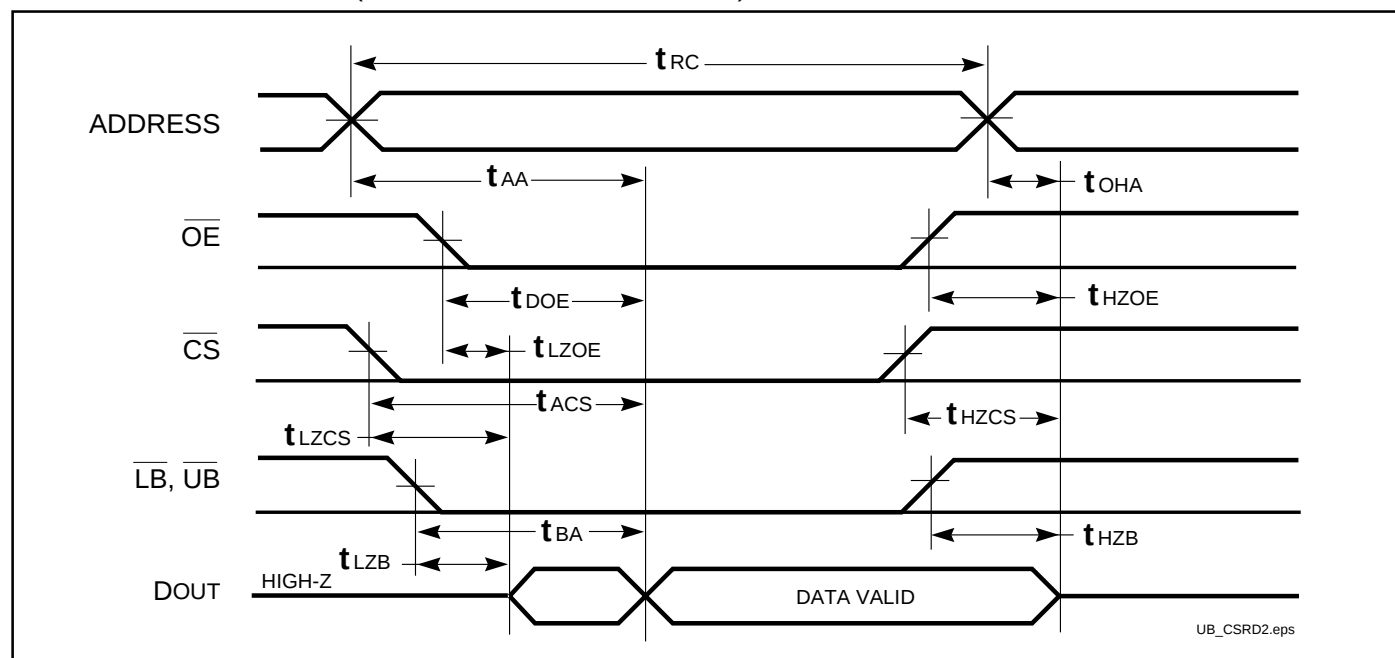
READ CYCLE SWITCHING CHARACTERISTICS⁽¹⁾ (Over Operating Range)

Symbol	Parameter	-70		-100		-120		Unit
		Min.	Max.	Min.	Max.	Min.	Max.	
t _{RC}	Read Cycle Time	70	—	100	—	120	—	ns
t _{AA}	Address Access Time	—	70	—	100	—	120	ns
t _{OH}	Output Hold Time	10	—	10	—	15	—	ns
t _{ACS}	$\overline{\text{CS}}$ Access Time	—	70	—	100	—	120	ns
t _{DOE}	$\overline{\text{OE}}$ Access Time	—	40	—	50	—	70	ns
t _{HZOE} ⁽²⁾	$\overline{\text{OE}}$ to High-Z Output	0	25	0	30	0	35	ns
t _{LZOE} ⁽²⁾	$\overline{\text{OE}}$ to Low-Z Output	5	—	5	—	5	—	ns
t _{HZCS} ⁽²⁾	$\overline{\text{CS}}$ to High-Z Output	0	25	0	30	0	35	ns
t _{LZCS} ⁽²⁾	$\overline{\text{CS}}$ to Low-Z Output	5	—	10	—	10	—	ns
t _{BA}	$\overline{\text{LB}}, \overline{\text{UB}}$ Access Time	—	70	—	100	—	120	ns
t _{HZB} ⁽²⁾	$\overline{\text{LB}}, \overline{\text{UB}}$ to High-Z Output	0	30	0	40	0	45	ns
t _{LZB} ⁽²⁾	$\overline{\text{LB}}, \overline{\text{UB}}$ to Low-Z Output	10	—	10	—	10	—	ns

Notes:

1. Test conditions assume signal transition times of 5 ns or less, timing reference levels of 1.5V, input pulse levels of 0 to 3V and output loading specified in Figure 1.
2. Tested with the load in Figure 2. Transition is measured $\pm 500\text{mV}$ from steady-state voltage. Not 100% tested.

AC WAVEFORMS

READ CYCLE NO. 1^(1,2) (Address Controlled) ($\overline{CS} = \overline{OE} = V_{IL}$, $\overline{UB}$ or $\overline{LB} = V_{IL}$)READ CYCLE NO. 2^(1,3) ($\overline{CS}$, $\overline{OE}$, and $\overline{UB}$ / $\overline{LB}$ Controlled)

Notes:

1. $\overline{WE}$ is HIGH for a Read Cycle.
2. The device is continuously selected. $\overline{OE}$, $\overline{CS}$, $\overline{UB}$, or $\overline{LB} = V_{IL}$.
3. Address is valid prior to or coincident with $\overline{CS}$ LOW transition.

WRITE CYCLE SWITCHING CHARACTERISTICS^(1,2) (Over Operating Range)

Symbol	Parameter	-70		-100		-120		Unit
		Min.	Max.	Min.	Max.	Min.	Max.	
t _{WC}	Write Cycle Time	70	—	100	—	120	—	ns
t _{SCS}	$\overline{CS}$ to Write End	60	—	80	—	100	—	ns
t _{AW}	Address Setup Time to Write End	60	—	80	—	100	—	ns
t _{HA}	Address Hold from Write End	0	—	0	—	0	—	ns
t _{SA}	Address Setup Time	0	—	0	—	0	—	ns
t _{PWB}	$\overline{LB}$, $\overline{UB}$ Valid to End of Write	60	—	80	—	100	—	ns
t _{PWE1,2}	$\overline{WE}$ Pulse Width	60	—	80	—	100	—	ns
t _{SD}	Data Setup to Write End	40	—	50	—	60	—	ns
t _{HD}	Data Hold from Write End	0	—	0	—	0	—	ns
t _{HZWE} ⁽³⁾	$\overline{WE}$ LOW to High-Z Output	0	25	0	30	0	—	ns
t _{LZWE} ⁽³⁾	$\overline{WE}$ HIGH to Low-Z Output	5	—	5	—	5	—	ns

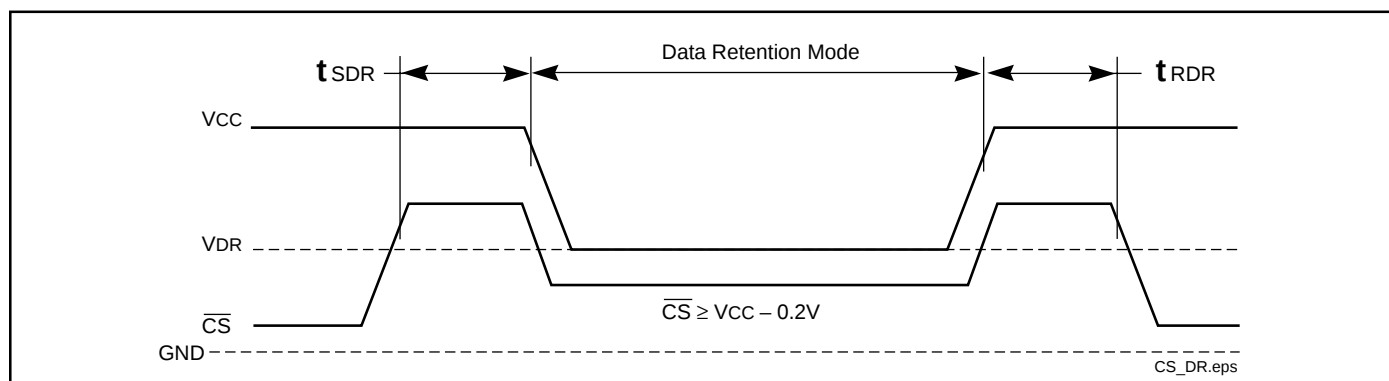
Notes:

1. Test conditions assume signal transition times of 5 ns or less, timing reference levels of 1.5V, input pulse levels of 0 to 3V and output loading specified in Figure 1.
2. The internal write time is defined by the overlap of $\overline{CS}$ LOW and $\overline{UB}$ or $\overline{LB}$, and $\overline{WE}$ LOW. All signals must be in valid states to initiate a Write, but any one can go inactive to terminate the Write. The Data Input Setup and Hold timing are referenced to the rising or falling edge of the signal that terminates the write.
3. Tested with the load in Figure 2. Transition is measured ± 500 mV from steady-state voltage.

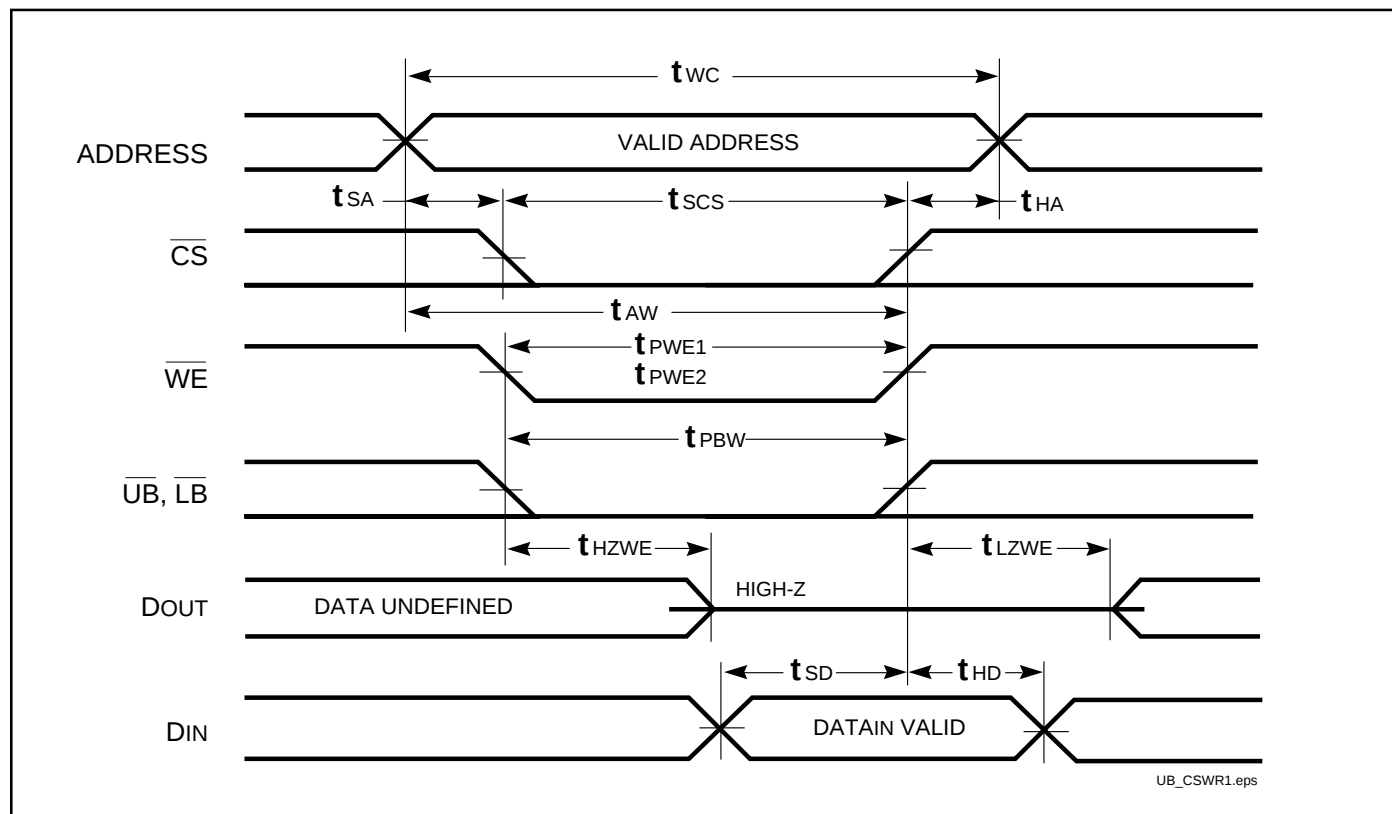
DATA RETENTION CHARACTERISTICS (L/LL)

Symbol	Parameter	Test Condition	Min.	Max.	Unit
V _{DR}	V _{CC} for Data Retention	$\overline{CS} \geq V_{CC} - 0.2V$	2.0	—	V
I _{DR}	Data Retention Current	$V_{CC} = V_{DR}$ $\overline{CS} \geq V_{CC} - 0.2V$	—	5.0	μA
t _{SDR}	Data Retention Set up Time	See Data Retention Waveform	0	—	ns
t _{RDR}	Recovery Time	See Data Retention Waveform	t _{RC}	—	ns

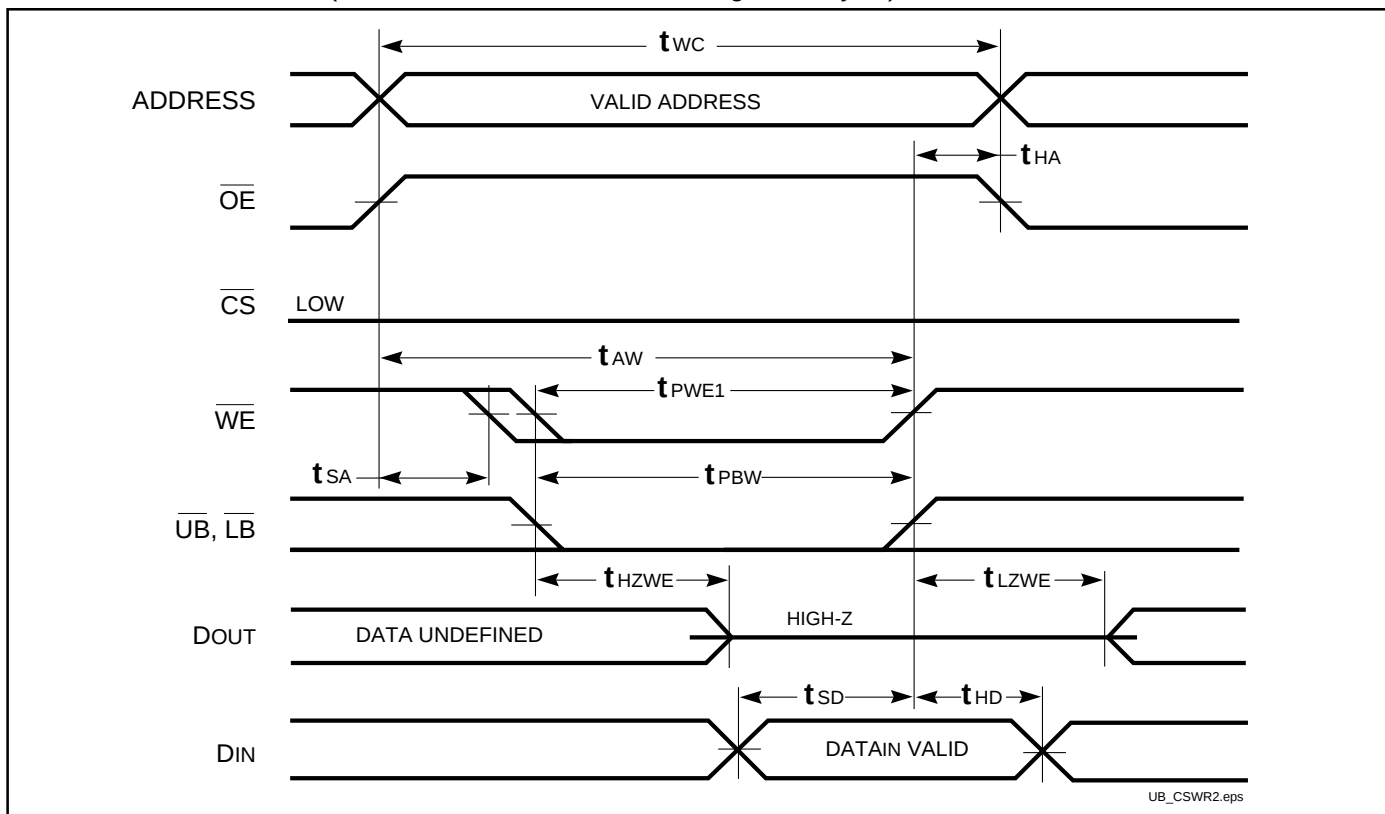
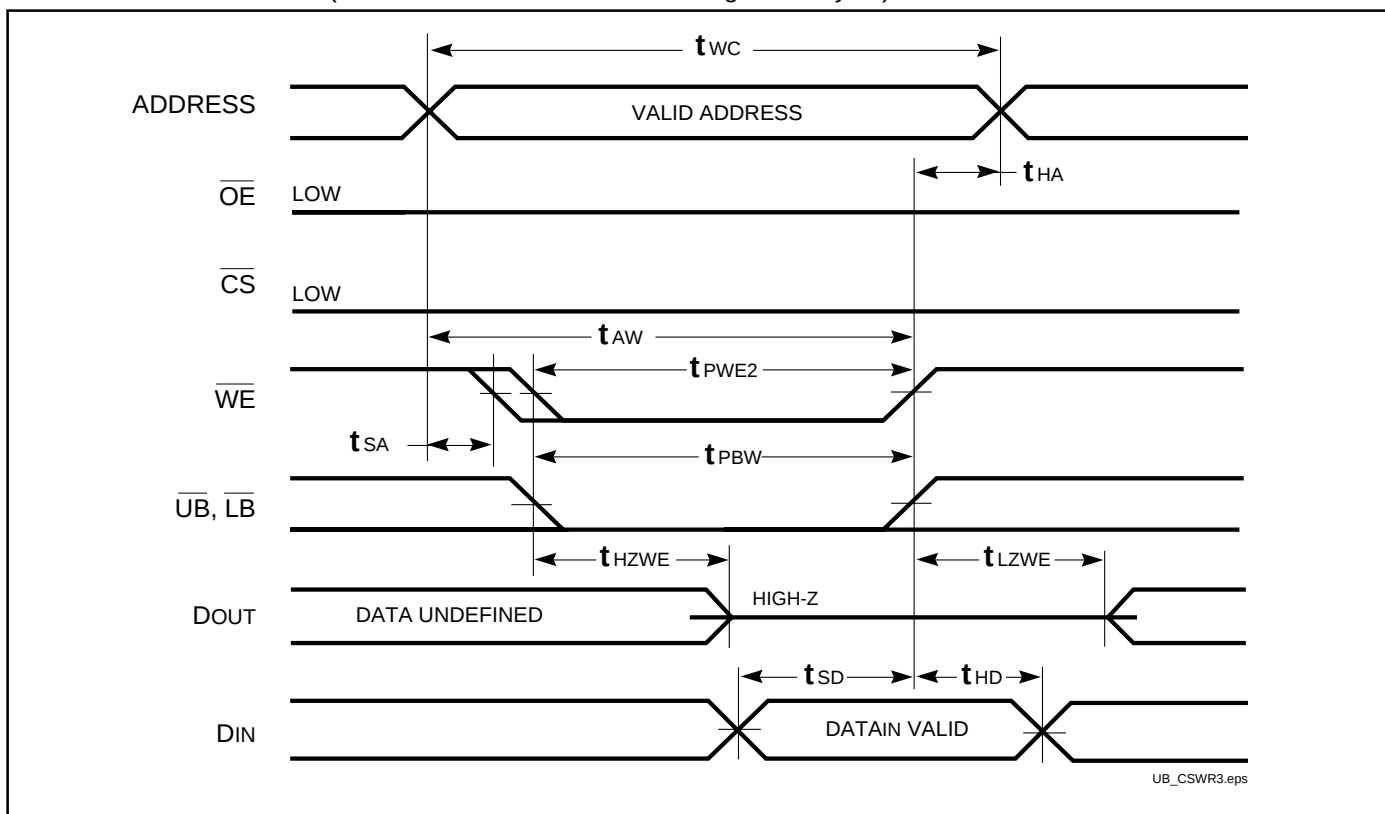
DATA RETENTION TIMING DIAGRAM

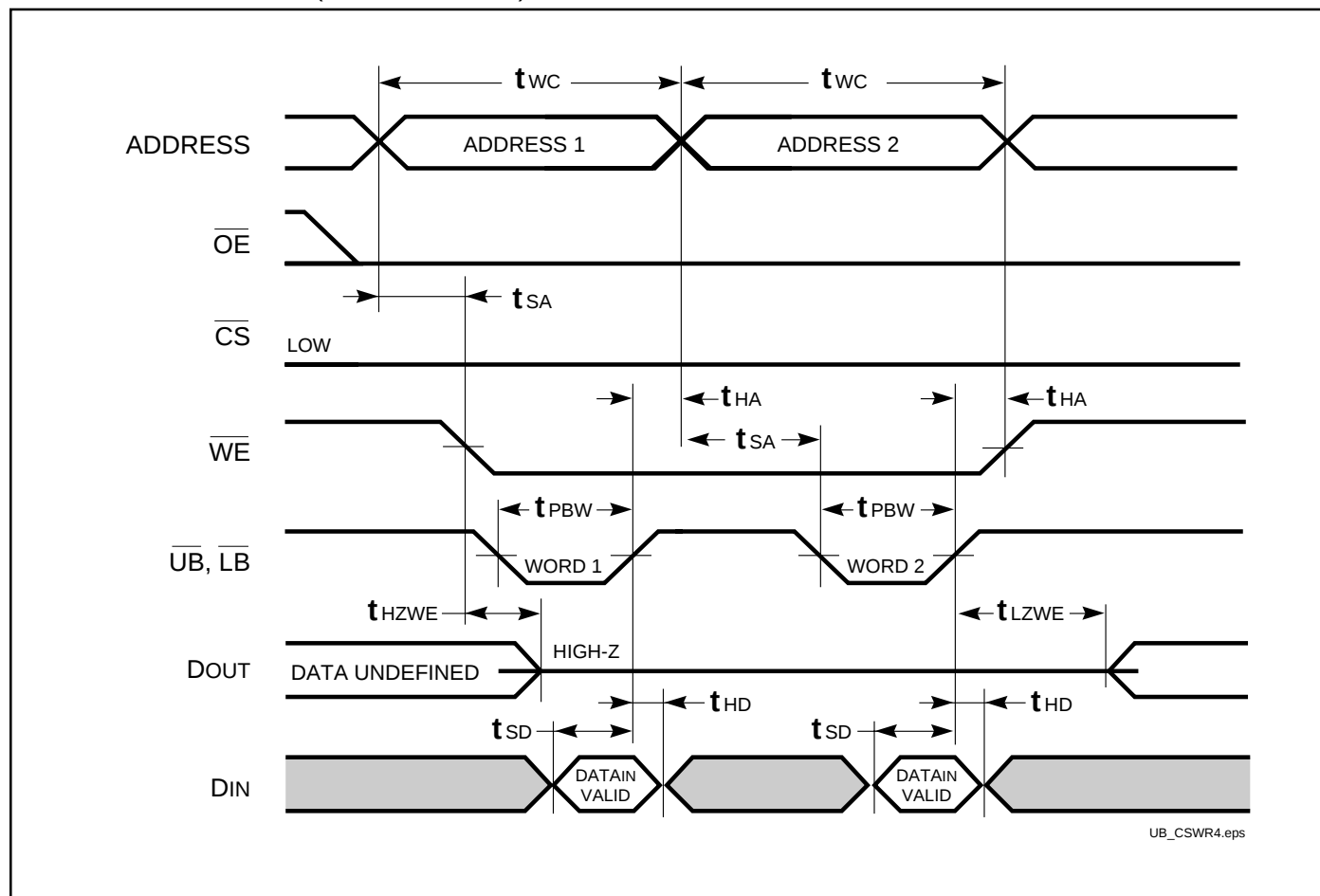


AC WAVEFORMS

WRITE CYCLE NO. 1^(1,2) ($\overline{CS}$ Controlled, $\overline{OE}$ = HIGH or LOW)**Notes:**

1. WRITE is an internally generated signal asserted during an overlap of the LOW states on the $\overline{CS}$ and $\overline{WE}$ inputs and at least one of the $\overline{LB}$ and $\overline{UB}$ inputs being in the LOW state.
2. WRITE = ($\overline{CS}$) [($\overline{LB}$) = ($\overline{UB}$)] ($\overline{WE}$).

WRITE CYCLE NO. 2 ($\overline{WE}$ Controlled: $\overline{OE}$ is HIGH During Write Cycle)**WRITE CYCLE NO. 3** ($\overline{WE}$ Controlled: $\overline{OE}$ is LOW During Write Cycle)

WRITE CYCLE NO. 4 ($\overline{\text{UB}}/\overline{\text{LB}}$ Controlled)

IS62V6416BL:**ORDERING INFORMATION****Commercial Range: 0°C to +70°C**

Speed (ns)	Order Part No.	Package
70	IS62V6416BL-70T	Plastic TSOP (Type II)
	IS62V6416BL-70K	400-mil Plastic SOJ
	IS62V6416BL-70B	Mini BGA (6mm x 8mm)
100	IS62V6416BL-10T	Plastic TSOP (Type II)
	IS62V6416BL-10K	400-mil Plastic SOJ
	IS62V6416BL-10B	Mini BGA (6mm x 8mm)
120	IS62V6416BL-12T	Plastic TSOP (Type II)
	IS62V6416BL-12K	400-mil Plastic SOJ
	IS62V6416BL-12B	Mini BGA (6mm x 8mm)

IS62V6416BL:**ORDERING INFORMATION****Industrial Range: -40°C to +85°C**

Speed (ns)	Order Part No.	Package
70	IS62V6416BL-70TI	Plastic TSOP (Type II)
	IS62V6416BL-70KI	400-mil Plastic SOJ
	IS62V6416BL-70BI	Mini BGA (6mm x 8mm)
100	IS62V6416BL-10TI	Plastic TSOP (Type II)
	IS62V6416BL-10KI	400-mil Plastic SOJ
	IS62V6416BL-10BI	Mini BGA (6mm x 8mm)
120	IS62V6416BL-12TI	Plastic TSOP (Type II)
	IS62V6416BL-12KI	400-mil Plastic SOJ
	IS62V6416BL-12BI	Mini BGA (6mm x 8mm)

IS62V6416BLL:**ORDERING INFORMATION****Commercial Range: 0°C to +70°C**

Speed (ns)	Order Part No.	Package
70	IS62V6416BLL-70T	Plastic TSOP (Type II)
	IS62V6416BLL-70K	400-mil Plastic SOJ
	IS62V6416BLL-70B	Mini BGA (6mm x 8mm)
100	IS62V6416BLL-10T	Plastic TSOP (Type II)
	IS62V6416BLL-10K	400-mil Plastic SOJ
	IS62V6416BLL-10B	Mini BGA (6mm x 8mm)
120	IS62V6416BLL-12T	Plastic TSOP (Type II)
	IS62V6416BLL-12K	400-mil Plastic SOJ
	IS62V6416BLL-12B	Mini BGA (6mm x 8mm)

IS62V6416BLL:**ORDERING INFORMATION****Industrial Range: -40°C to +85°C**

Speed (ns)	Order Part No.	Package
70	IS62V6416BLL-70TI	Plastic TSOP (Type II)
	IS62V6416BLL-70KI	400-mil Plastic SOJ
	IS62V6416BLL-70BI	Mini BGA (6mm x 8mm)
100	IS62V6416BLL-10TI	Plastic TSOP (Type II)
	IS62V6416BLL-10KI	400-mil Plastic SOJ
	IS62V6416BLL-10BI	Mini BGA (6mm x 8mm)
120	IS62V6416BLL-12TI	Plastic TSOP (Type II)
	IS62V6416BLL-12KI	400-mil Plastic SOJ
	IS62V6416BLL-12BI	Mini BGA (6mm x 8mm)

ISSI®**Integrated Silicon Solution, Inc.**

2231 Lawson Lane

Santa Clara, CA 95054

Tel: 1-800-379-4774

Fax: (408) 588-0806

E-mail: sales@issi.com

www.issi.com